# Quick Guide to Precision Measuring Instruments



# Laser Scan Micrometers

# Compatibility

Your Laser Scan Micrometer has been adjusted together with the ID Unit, which is supplied with the measuring unit. The ID Unit, which has the same code number and the same serial number as the measuring unit, must be installed in the display unit. This means that if the ID Unit is replaced the measuring unit can be connected to another corresponding display unit.

### The workpiece and measuring conditions

Depending on whether the laser is visible or invisible, the workpiece shape, and the surface roughness, measurement errors may result. If this is the case, perform calibration with a master workpiece which has dimensions, shape, and surface roughness similar to the actual workpiece to be measured. If measurement values show a large degree of dispersion due to the measuring conditions, increase the number of scans for averaging to improve the measurement accuracy.

## **Electrical interference**

To avoid operational errors, do not route the signal cable and relay cable of the Laser Scan Micrometer alongside a high voltage line or other cables capable of inducing noise current in nearby conductors. Ground all appropriate units and cable shields.

#### **Connection to a computer**

If the Laser Scan Micrometer is to be connected to an external personal computer via the RS-232C interface, ensure that the cable connections conform to the specification.

#### **Laser safety**

Mitutoyo Laser Scan Micrometers use a low-power visible laser for measurement. The laser is a CLASS 2 EN/IEC60825-1 device. Warning and explanation labels, as shown below, are attached to the Laser Scan Micrometers as is appropriate.



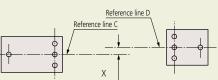
#### Re-assembly after removal from the base

Observe the following limits when re-assembling the emission unit and reception unit to minimize measurement errors due to misalignment of the laser's optical axis with the reception unit.

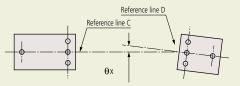
#### • Alignment within the horizontal plane

a. Parallel deviation between reference lines C and D:

X (in the transverse direction)

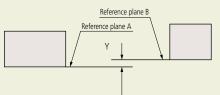


b. Angle between reference lines C and D:  $\Theta x$  (angle)

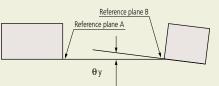


#### • Alignment within the vertical plane

c. Parallel deviation between reference planes A and B: Y (in height)



d. Angle between reference planes A and B:  $\Theta$ y (angle)



#### • Allowable limits of optical axis misalignment

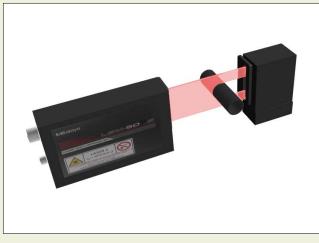
Model	Distance between Emission Unit and Reception Unit	X and Y	$\theta x$ and $\theta y$
LSM-501S	68 mm (2.68 in) or less	within 0.5 mm (0.02 in)	within 0.4° (7 mrad)
	100 mm (3.94 in) or less	within 0.5 mm (0.02 in)	within 0.3° (5.2 mrad)
LSM-503S	130 mm (5.12 in) or less	within 1 mm (0.04 in)	within 0.4° (7 mrad)
	350 mm (13.78 in) or less	within 1 mm (0.04 in)	within 0.16° (2.8 mrad)
LSM-506S	273 mm (10.75 in) or less	within 1 mm (0.04 in)	within 0.2° (3.5 mrad)
	700 mm (27.56 in) or less	within 1 mm (0.04 in)	within 0.08° (1.4 mrad)
LSM-512S	321 mm (12.64 in) or less	within 1 mm (0.04 in)	within 0.18° (3.1 mrad)
	700 mm (27.56 in) or less	within 1 mm (0.04 in)	within 0.08° (1.4 mrad)
LSM-516S	800 mm (31.50 in) or less	within 1 mm (0.04 in)	within 0.09° (1.6 mrad)



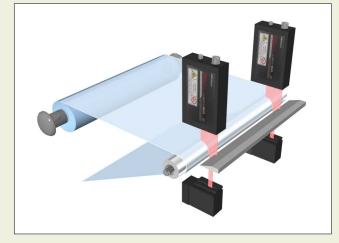


# **Measurement Examples**

#### Measurement of outside diameter of rubber roll



Measurement of uneven thickness of film or sheet (simultaneous measurement)



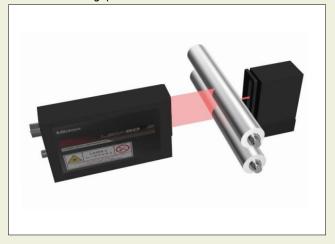
Measurement of film sheet thickness



Simultaneous measurement of roller outside diameter and deflection



Measurement of gap between rollers



Dual system for measuring a large outside diameter





Mitutoyo